

**Notice of References Cited**

Application/Control No.

10/529,071

Applicant(s)/Patent Under

Reexamination

LI ET AL.

Examiner

Scott D. Long

Art Unit

1633

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
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	J	US-			
	K	US-			
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**NON-PATENT DOCUMENTS**

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